



JCO4 Rec'd PCT/PTO -2 AUG 2005

PCT

PATENT
3511-1003

IN THE U.S. PATENT AND TRADEMARK OFFICE

In re application of

Iiro HIETANEN et al.

Application No. 10/533,645

Filed May 3, 2005

SYNCRHONOUS OPTICAL MEASUREMENT
AND INSPECTION METHOD AND MEANS

INFORMATION DISCLOSURE STATEMENT

Assistant Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

August 2, 2005

Sir:

In compliance with Rules 1.97 and 1.98, and in fulfillment of the duty of disclosure under Rule 1.56, the accompanying documents, copies of which are attached to this statement, are made of record on the enclosed sheet.

A concise explanation of the relevance of these items is that these references were discovered during any searches they or their client had made, or that they were considered in the preparation of the application.

Respectfully submitted,

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RJP/lk

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

* Abstract provided for the Examiner's convenience